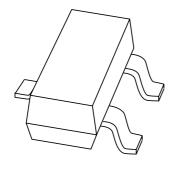
### **DISCRETE SEMICONDUCTORS**

# DATA SHEET



### BAS29; BAS31; BAS35 General purpose controlled avalanche (double) diodes

Product data sheet Supersedes data of 2001 Oct 10 2003 Mar 20



## General purpose controlled avalanche (double) diodes

**BAS29**; **BAS31**; **BAS35** 

#### **FEATURES**

• Small plastic SMD package

• Switching speed: max. 50 ns

· General application

• Continuous reverse voltage: max. 90 V

• Repetitive peak reverse voltage: max. 110 V

• Repetitive peak forward current: max. 600 mA

• Repetitive peak reverse current: max. 600 mA.

#### **APPLICATIONS**

General purpose switching in e.g. surface mounted circuits.

#### **DESCRIPTION**

General purpose switching diodes fabricated in planar technology, and encapsulated in small rectangular plastic SMD SOT23 packages. The BAS29 consists of a single diode. The BAS31 has two diodes in series. The BAS35 has two diodes with a common anode.

#### **MARKING**

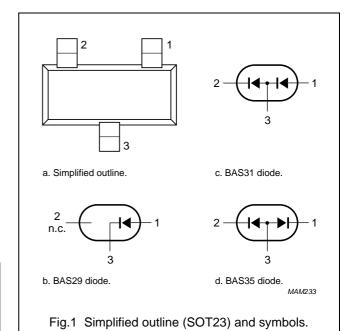
| TYPE NUMBER | MARKING CODE(1) |
|-------------|-----------------|
| BAS29       | L20 or *A8      |
| BAS31       | L21 or *V1      |
| BAS35       | L22 or *V2      |

#### Note

\* = p : Made in Hong Kong.
\* = t : Made in Malaysia.
\* = W : Made in China.

#### **PINNING**

| PIN | DESCRIPTION   |                   |              |  |
|-----|---------------|-------------------|--------------|--|
| FIN | BAS29         | BAS29 BAS31 BAS35 |              |  |
| 1   | anode         | anode             | cathode (k1) |  |
| 2   | not connected | cathode           | cathode (k2) |  |
| 3   | cathode       | common connection | common anode |  |



# General purpose controlled avalanche (double) diodes

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#### **LIMITING VALUES**

In accordance with the Absolute Maximum Rating System (IEC 60134).

| SYMBOL           | PARAMETER CONDITIONS                |   | MIN. | MAX. | UNIT |
|------------------|-------------------------------------|---|------|------|------|
| Per diode        |                                     |   |      |      | •    |
| $V_{RRM}$        | repetitive peak reverse voltage     |   | _    | 110  | V    |
| $V_R$            | continuous reverse voltage          |   | _    | 90   | V    |
| I <sub>F</sub>   | continuous forward current          | single diode loaded; see Fig.2; note 1                        | _    | 250  | mA   |
|                  |                                     | double diode loaded; see Fig.2; note 1                        | _    | 150  | mA   |
| I <sub>FRM</sub> | repetitive peak forward current     |   | _    | 600  | mA   |
| I <sub>FSM</sub> | non-repetitive peak forward current | square wave; T <sub>j</sub> = 25 °C prior to surge; see Fig.4 |      |      |      |
|                  |                                     | t = 1 μs  | _    | 10   | Α    |
|                  |                                     | t = 100 μs  | _    | 4    | Α    |
|                  |                                     | t = 1 s   | _    | 0.75 | Α    |
| P <sub>tot</sub> | total power dissipation             | T <sub>amb</sub> = 25 °C; note 1                              | _    | 250  | mW   |
| I <sub>RRM</sub> | repetitive peak reverse current     |   | _    | 600  | mA   |
| E <sub>RRM</sub> | repetitive peak reverse energy      | $t_p \ge 50 \ \mu s; \ f \le 20 \ Hz; \ T_j = 25 \ ^{\circ}C$ | _    | 5    | mJ   |
| T <sub>stg</sub> | storage temperature                 |   | -65  | +150 | °C   |
| Tj               | junction temperature                |   | _    | 150  | °C   |

#### Note

<sup>1.</sup> Device mounted on an FR4 printed-circuit board.

# General purpose controlled avalanche (double) diodes

BAS29; BAS31; BAS35

#### **ELECTRICAL CHARACTERISTICS**

 $T_j = 25$  °C unless otherwise specified.

| SYMBOL             | PARAMETER CONDITIONS                |   | MIN. | MAX. | UNIT |  |
|--------------------|-------------------------------------|---|------|------|------|--|
| Per diode          | Per diode                           |   |      |      |      |  |
| V <sub>F</sub>     | forward voltage                     | see Fig.3   |      |      |      |  |
|                    |                                     | I <sub>F</sub> = 10 mA  | _    | 750  | mV   |  |
|                    |                                     | I <sub>F</sub> = 50 mA  | _    | 840  | mV   |  |
|                    |                                     | I <sub>F</sub> = 100 mA   | _    | 900  | mV   |  |
|                    |                                     | I <sub>F</sub> = 200 mA   | _    | 1    | V    |  |
|                    |                                     | I <sub>F</sub> = 400 mA   | _    | 1.25 | V    |  |
| I <sub>R</sub>     | reverse current                     | see Fig.5   |      |      |      |  |
|                    |                                     | V <sub>R</sub> = 90 V   | _    | 100  | nA   |  |
|                    |                                     | V <sub>R</sub> = 90 V; T <sub>j</sub> = 150 °C  | _    | 100  | μΑ   |  |
| V <sub>(BR)R</sub> | reverse avalanche breakdown voltage | I <sub>R</sub> = 1 mA   | 120  | 170  | V    |  |
| C <sub>d</sub>     | diode capacitance                   | $f = 1 \text{ MHz}; V_R = 0; \text{ see Fig.6}$   | _    | 35   | pF   |  |
| t <sub>rr</sub>    | reverse recovery time               | when switched from $I_F$ = 30 mA to $I_R$ = 30 mA; $R_L$ = 100 $\Omega$ ; measured at $I_R$ = 3 mA; see Fig.7 | _    | 50   | ns   |  |

#### THERMAL CHARACTERISTICS

| SYMBOL               | PARAMETER                                     | CONDITIONS | VALUE | UNIT |
|----------------------|---|------------|-------|------|
| R <sub>th j-tp</sub> | thermal resistance from junction to tie-point |            | 360   | K/W  |
| R <sub>th j-a</sub>  | thermal resistance from junction to ambient   | note 1     | 500   | K/W  |

#### Note

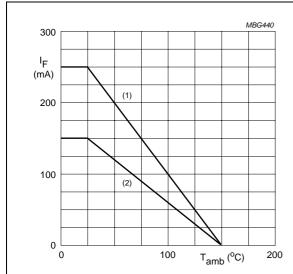
1. Device mounted on an FR4 printed-circuit board.

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## General purpose controlled avalanche (double) diodes

BAS29; BAS31; BAS35

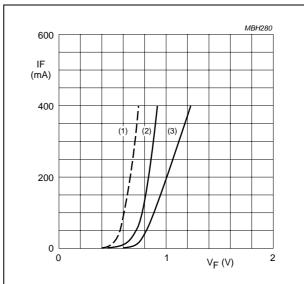
#### **GRAPHICAL DATA**



Device mounted on an FR4 printed-circuit board.

- (1) Single diode loaded.
- (2) Double diode loaded.

Fig.2 Maximum permissible continuous forward current as a function of ambient temperature.



- (1)  $T_j = 150$  °C; typical values.
- (2)  $T_j = 25$  °C; typical values.
- (3)  $T_j = 25$  °C; maximum values.

Fig.3 Forward current as a function of forward voltage.

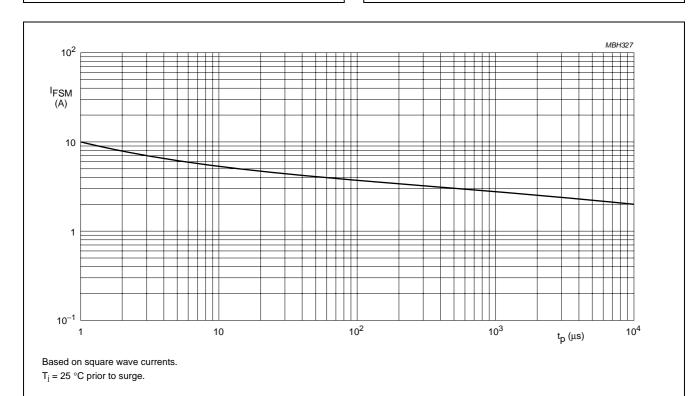
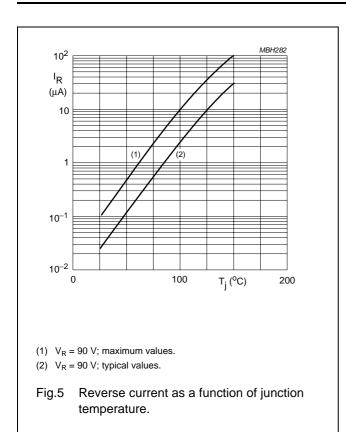
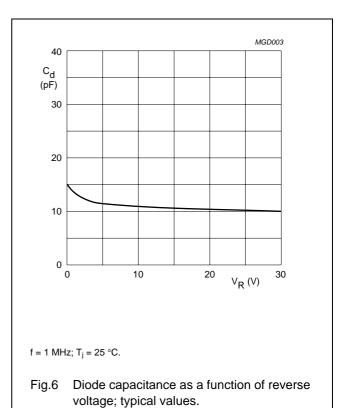


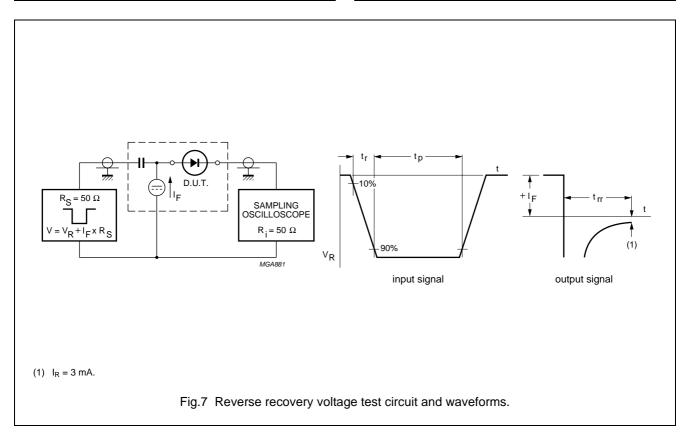
Fig.4 Maximum permissible non-repetitive peak forward current as a function of pulse duration.

# General purpose controlled avalanche (double) diodes

BAS29; BAS31; BAS35







# General purpose controlled avalanche (double) diodes

BAS29; BAS31; BAS35

#### **PACKAGE OUTLINE**

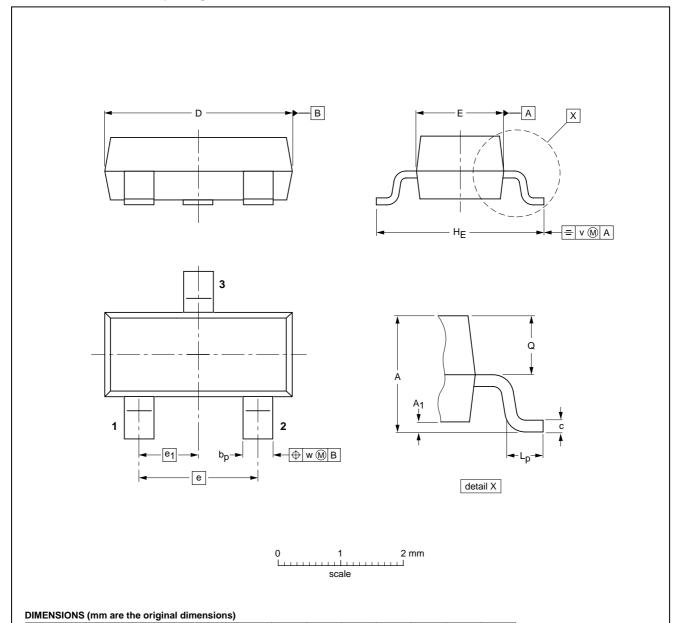
UNIT

mm

Α

Plastic surface mounted package; 3 leads

SOT23



| OUTLINE |     | REFERENCES |      | EUROPEAN | ISSUE DATE |                                 |
|---------|-----|------------|------|----------|------------|---------------------------------|
| VERSION | IEC | JEDEC      | EIAJ |          | PROJECTION | ISSUE DATE                      |
| SOT23   |     | TO-236AB   |      |          |            | <del>97-02-28</del><br>99-09-13 |

Q

0.55

0.45

w

0.1

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 $b_p$ 

0.48

0.38

0.1

D

3.0

2.8

С

0.15

0.09

Ε

1.4

е

1.9

e<sub>1</sub>

0.95

 $H_{\mathsf{E}}$ 

 $L_{p}$ 

0.45

0.15

### General purpose controlled avalanche (double) diodes

BAS29; BAS31; BAS35

#### **DATA SHEET STATUS**

| DOCUMENT<br>STATUS <sup>(1)</sup> | PRODUCT<br>STATUS <sup>(2)</sup> | DEFINITION  |
|-----------------------------------|----------------------------------|---|
| Objective data sheet              | Development                      | This document contains data from the objective specification for product development. |
| Preliminary data sheet            | Qualification                    | This document contains data from the preliminary specification.                       |
| Product data sheet                | Production                       | This document contains the product specification.                                     |

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